

PECLERS

DESCRIPTION

PECH3401VRG

30V P-Channel Enhancement Mode MOSFET

The PECH3401VRG uses advanced trench technology to provide excellent $R_{DS(ON)}$, low gate charge and high density cell Design for ultra low on-resistance. This device is suitable for use as a load switch or in PWM applications.

GENERAL FEATURES

- ◇ $V_{DS} = -30V$, $I_D = -4.2A$
 $R_{DS(ON)}(Typ.) = 73m\Omega$ @ $V_{GS} = -2.5V$
 $R_{DS(ON)}(Typ.) = 53m\Omega$ @ $V_{GS} = -4.5V$
- ◇ High power and current handling capability
- ◇ Lead free product is acquired
- ◇ Surface mount package

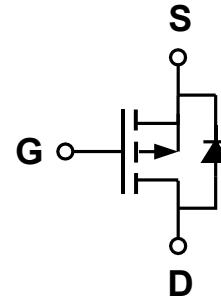
APPLICATION

- ◇ PWM applications
- ◇ Load switch

PACKAGE

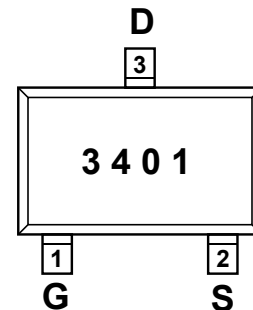
- ◇ SOT-23

SCHEMATIC DIAGRAM



PIN ASSIGNMENT

SOT-23
(TOP VIEW)



ORDERING INFORMATION

Part Number	Storage Temperature	Package	Marking	Devices Per Reel
PECH3401VRG	-55°C to +150°C	SOT-23	3401	3000

ABSOLUTE MAXIMUM RATINGS

(TA=25°C unless otherwise noted)

parameter	symbol	limit	unit
Drain-source voltage	V _{DS}	-30	V
Gate-source voltage	V _{GS}	±12	V
Continuous Drain Current (T _J = 150 °C)	T _C =25°C	-4.2	A
	T _C =70°C	-3.7	
	T _A =25°C	-3.8 ^{b,c}	
	T _A =70°C	-2.9 ^{b,c}	
Continuous Source-Drain Diode Current	T _C =25°C	-1.4	A
	T _A =25°C	-1 ^{b,c}	
Pulsed Drain Current (t = 300 μs)	I _{DM}	14	
Maximum power dissipation	T _C =25°C	1.7	W
	T _C =70°C	1.1	

	T _A =25°C		1 ^{b,c}	
	T _A =70°C		0.6 ^{b,c}	
Operating Junction and Storage Temperature Range		T _J , T _{STG}	-55—150	°C

THERMAL CHARACTERISTICS

Parameter	Symbol	Typ	Max	Unit
Maximum junction-to-ambient ^a	≤ 5 s	120	145	°C/W
	Steady-State	140	175	
Maximum junction-to-foot	Steady-State	62	78	

Notes

- Surface mounted on 1" x 1" FR4 board
- Pulse width limited by maximum junction temperature

ELECTRICAL CHARACTERISTICS (T_A=25°C unless otherwise noted)

Parameter	Symbol	Condition	Min	Typ	Max	Unit
OFF Characteristics						
Drain-source breakdown voltage	BV _{DSS}	V _{GS} =0V, I _D =-250μA	-30	-	-	V
Zero gate voltage drain current	I _{DSS}	V _{DS} =-30V, V _{GS} =0V	-	-	-1	μA

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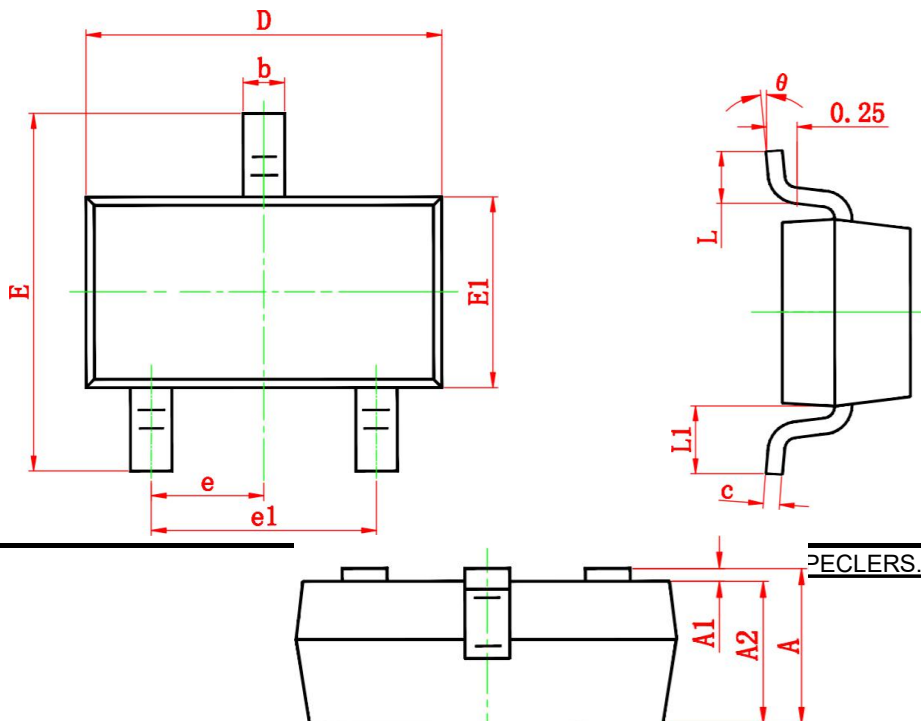
Gate-body leakage	I_{GSS}	$V_{DS}=0V, V_{GS}=\pm 12V$	-	-	± 100	nA
ON Characteristics						
Gate threshold voltage	$V_{GS(th)}$	$V_{DS}=V_{GS}, I_D=-250\mu A$	-0.5	-0.83	-1.3	V
Drain-source on-state resistance ^a	$R_{DS(ON)}$	$V_{GS}=-4.5V, I_D=-4A$	-	53	65	m Ω
		$V_{GS}=-2.5V, I_D=-2A$	-	73	85	
Forward transconductance ^a	g_{fs}	$V_{DS}=-5V, I_D=-4A$	-	11	-	S
Dynamic Characteristics ^b						
Input capacitance	C_{ISS}	$V_{DS}=-15V, V_{GS}=0V$ $f=1.0MHz$	-	880	-	pF
Output capacitance	C_{OSS}		-	105	-	
Reverse transfer capacitance	C_{RSS}		-	65	-	
Switching Characteristics						
Turn-on delay time	$t_{D(ON)}$	$V_{DD}=-15V$ $I_D=-4A$ $V_{GEN}=-10V$ $R_L=3.6ohm$ $R_{GEN}=6ohm$	-	7	-	ns
Rise time	t_r		-	3	-	
Turn-off delay time	$t_{D(OFF)}$		-	30	-	
Fall time	t_f		-	12	-	
Total gate charge	Q_g	$V_{DS}=-15V, I_D=-4A$ $V_{GS}=-4.5V$	-	8.5	-	nC
Gate-source charge	Q_{gs}		-	1.8	-	
Gate-drain charge	Q_{gd}		-	2.7	-	
DRAIN-SOURCE DIODE CHARACTERISTICS						
Diode forward voltage	V_{SD}	$V_{GS}=0V, I_s=-4A$	-	-0.81	-1.2	V

Notes

- a. Pulse test: Pulse width $\leq 300 \mu s$, duty cycle $\leq 2 \%$
- b. Guaranteed by design, not subject to production testing

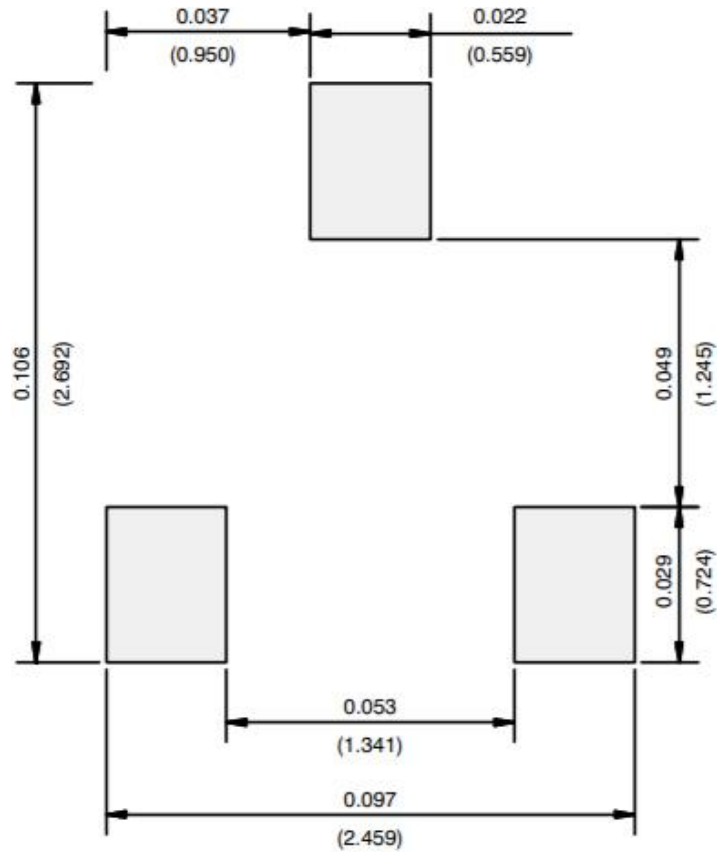
PACKAGE INFORMATION

- SOT-23



Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min.	Max.	Min.	Max.
A	0.900	1.150	0.035	0.045
A1	0.000	0.100	0.000	0.004
A2	0.900	1.050	0.035	0.041
b	0.300	0.500	0.012	0.020
c	0.080	0.150	0.003	0.006
D	2.800	3.000	0.110	0.118
E	2.250	2.550	0.089	0.100
E1	1.200	1.400	0.047	0.055
e	0.950 TYP.		0.037 TYP.	
e1	1.800	2.000	0.071	0.079
L	0.300	0.500	0.012	0.020
L1	0.550 REF.		0.022 REF.	
θ	0°	8°	0°	8°

RECOMMENDED MINIMUM PADS FOR SOT-23



Recommended Minimum Pads
Dimensions in Inches/(mm)